



RADIO TEST REPORT

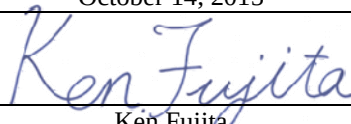
Test Report No. : 10980809H-A

Applicant : TOKAI RIKA CO., LTD.
Type of Equipment : Electronic Key
Model No. : BR1ET
Test regulation : FCC Part 15 Subpart C: 2015
FCC ID : MOZBR1ET
Test Result : Complied

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2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.
6. This test report covers Radio technical requirements. It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)

Date of test: October 14, 2015

Representative test engineer:


Ken Fujita
Engineer
Consumer Technology Division

Approved by:


Motoya Imura
Engineer
Consumer Technology Division



NVLAP LAB CODE: 200572-0

This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation.
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Ise EMC Lab.

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13-EM-F0429

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SECTION 1: Customer information

Company Name : TOKAI RIKA CO., LTD.
Address : 260 Toyota 3-chome, Oguchi-cho, Niwa-gun, Aichi-ken 480-0195 Japan
Telephone Number : +81-587-95-0093
Facsimile Number : +81-587-95-5471
Contact Person : Hiroki Unno

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment : Electronic Key
Model No. : BR1ET
Serial No. : Refer to Clause 4.2
Rating : DC 3.0 V
Receipt Date of Sample : October 14, 2015
Condition of EUT : Engineering prototype
(Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT : No Modification by the test lab

2.2 Product Description

Model No: BR1ET (referred to as the EUT in this report) is the Electronic Key for Smart Key System and Remote Keyless Entry System.

General Specification

Clock frequency(ies) in the system : 8 MHz, 18.37 MHz

Radio Specification

Radio Type : Transceiver
Frequency of Operation : CH 1: 314.35 MHz
CH 2: 312.10 MHz
Modulation : FSK
Method of Frequency Generation : Crystal
Antenna type : Pattern Antenna
Power Supply (radio part input) : DC 3.0 V
Operating Voltage Range : DC 2.5 to 3.2 V

Radio Type : Receiver
Frequency of Operation : 134.2 kHz

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 15 Subpart C: 2015, final revised on September 8, 2015

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.231 Periodic operation in the band 40.66 - 40.70MHz
and above 70MHz

3.2 Procedures and results

Item	Test Procedure	Specification	Worst margin	Results	Remarks
Conducted emission	FCC: ANSI C63.4:2009 7. AC powerline conducted emission measurements IC: RSS-Gen 8.8	FCC: Section 15.207 IC: RSS-Gen 8.8	N/A	N/A*1)	-
Automatically Deactivate	FCC: ANSI C63.4:2009 13. Measurement of intentional radiators IC: -	FCC: Section 15.231(a)(1) IC: RSS-210 A1.1.1	N/A	Complied	Radiated
Electric Field Strength of Fundamental Emission	FCC: ANSI C63.4:2009 13. Measurement of intentional radiators IC: RSS-Gen 6.12	FCC: Section 15.231(b) IC: RSS-210 A1.1.2	2.0 dB 314.350 MHz Horizontal PK (PK with Duty factor)	Complied	Radiated
Electric Field Strength of Spurious Emission	FCC: ANSI C63.4:2009 13. Measurement of intentional radiators IC: RSS-Gen 6.13	FCC: Section 15.205 Section 15.209 Section 15.231(b) IC: RSS-210 A1.1.2, 2.5.1 RSS-Gen 8.9	6.5 dB 2829.150 MHz Horizontal PK (PK with Duty factor) (Tx: 314.35 MHz)	Complied	Radiated
-20dB Bandwidth	FCC: ANSI C63.4:2009 13. Measurement of intentional radiators IC: -	FCC: Section 15.231(c) IC: Reference data	N/A	Complied	Radiated

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

*1) The test is not applicable since the EUT does not have AC Mains.

FCC Part 15.31 (e)

The test was performed with the New Battery (DC 3.0 V) during the tests. Therefore, the EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

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3.3 Addition to standard

Item	Test Procedure	Specification	Worst margin	Results	Remarks
99 % Occupied Bandwidth	IC: RSS-Gen 6.6	IC: RSS-210 A1.1.3	N/A	Complied	Radiated

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

EMI

The following uncertainties have been calculated to provide a confidence level of 95 % using a coverage factor $k = 2$.

Test room (semi-anechoic chamber)	Radiated emission						
	(3 m*)(+dB)				(1 m*)(+dB)		(0.5 m*)(+dB)
	9 kHz - 30 MHz	30 MHz - 300 MHz	300 MHz - 1 GHz	1 GHz - 10 GHz	10 GHz - 18 GHz	18 GHz - 26.5 GHz	26.5 GHz - 40 GHz
No.1	4.3 dB	5.1 dB	6.2 dB	5.5 dB	5.8 dB	5.8 dB	4.3 dB
No.2	4.2 dB	5.1 dB	6.2 dB	5.4 dB	5.7 dB	5.9 dB	5.6 dB
No.3	4.4 dB	5.1 dB	6.3 dB	5.2 dB	5.5 dB	5.8 dB	5.5 dB
No.4	4.7 dB	5.3 dB	6.3 dB	5.3 dB	5.7 dB	5.9 dB	5.5 dB

*3 m / 1 m / 0.5 m = Measurement distance

Radiated emission test(3 m)

[Electric Field Strength of Fundamental Emission]

The data listed in this report meets the limits unless the uncertainty is taken into consideration.

[Electric Field Strength of Spurious Emission]

The data listed in this test report has enough margin, more than the site margin.

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3.5 Test Location

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	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms
No.1 semi-anechoic chamber	2973C-1	19.2 x 11.2 x 7.7m	7.0 x 6.0m	No.1 Power source room
No.2 semi-anechoic chamber	2973C-2	7.5 x 5.8 x 5.2m	4.0 x 4.0m	-
No.3 semi-anechoic chamber	2973C-3	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.3 Preparation room
No.3 shielded room	-	4.0 x 6.0 x 2.7m	N/A	-
No.4 semi-anechoic chamber	2973C-4	12.0 x 8.5 x 5.9m	6.8 x 5.75m	No.4 Preparation room
No.4 shielded room	-	4.0 x 6.0 x 2.7m	N/A	-
No.5 semi-anechoic chamber	-	6.0 x 6.0 x 3.9m	6.0 x 6.0m	-
No.6 shielded room	-	4.0 x 4.5 x 2.7m	4.0 x 4.5 m	-
No.6 measurement room	-	4.75 x 5.4 x 3.0m	4.75 x 4.15 m	-
No.7 shielded room	-	4.7 x 7.5 x 2.7m	4.7 x 7.5m	-
No.8 measurement room	-	3.1 x 5.0 x 2.7m	N/A	-
No.9 measurement room	-	8.0 x 4.6 x 2.8m	2.4 x 2.4m	-
No.11 measurement room	-	6.2 x 4.7 x 3.0m	4.8 x 4.6m	-

* Size of vertical conducting plane (for Conducted Emission test): 2.0 x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test data, Test instruments, and Test set up.

Refer to APPENDIX.

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SECTION 4: Operation of E.U.T. during testing

4.1 Operating Modes

Test Item*	Mode
Automatically Deactivate	Normal use mode
Electric Field Strength of Fundamental Emission Electric Field Strength of Spurious Emission -20 dB & 99 % Occupied Bandwidth	Transmitting mode (Tx) *1)
* The system was configured in typical fashion (as a user would normally use it) for testing. *1) The software of this mode is the same as one of normal product, except that EUT continues to transmit when transmitter button is being pressed (For Normal use mode, EUT stops to transmit in a given time, even if transceiver button is being pressed.) End users cannot change the settings of the output power of the product.	

4.2 Configuration and peripherals

A

* Test data was taken under worse case conditions.

Description of EUT

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Electronic Key	BR1ET	001	TOKAI RIKAI CO., LTD	EUT

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SECTION 5: Radiated emission (Electric Field Strength of Fundamental and Spurious Emission)

Test Procedure and conditions

EUT was placed on a urethane platform of nominal size, 0.5 m by 1.0 m, raised 0.8 m above the conducting ground plane. The EUT was set on the center of the tabletop.
Test was made with the antenna positioned in both the horizontal and vertical planes of polarization. The measurement antenna was varied in height above the conducting ground plane to obtain the maximum signal strength.
Photographs of the set up are shown in Appendix 3.

[Transmitting mode]

(Below 30 MHz)

The noise level was checked by moving a search-coil (Loop Antenna) close to the EUT.

(Above 30 MHz)

The Radiated Electric Field Strength has been measured on Semi anechoic chamber with a ground plane and at a distance of 3 m.

The measuring antenna height was varied between 1 and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field strength.

The measurements were performed for both vertical and horizontal antenna polarization.

The radiated emission measurements were made with the following detector function of the test receiver / spectrum analyzer.

Test Antennas are used as below;

Frequency	Below 30 MHz	30 MHz to 300 MHz	300 MHz to 1 GHz	Above 1 GHz
Antenna Type	Loop	Biconical	Logperiodic	Horn

	From 9 kHz to 90 kHz and From 110 kHz to 150 kHz	From 90 kHz to 110 kHz	From 150 kHz to 490 kHz	From 490 kHz to 30 MHz	From 30 MHz to 1 GHz	Above 1 GHz
Detector Type	Peak	Peak	Peak	Peak	Peak and Peak with Duty factor	Peak and Peak with Duty factor
IF Bandwidth	200 Hz	200 Hz	9.1 kHz	9.1 kHz	120 kHz	PK: S/A: RBW 1 MHz, VBW: 3 MHz

- The carrier level (or, noise levels) was (or were) measured at each position of all three axes X, Y and Z, and the position that has the maximum noise was determined.

Noise levels of all the frequencies were measured at the position.

This EUT has two modes which mechanical key is inserted or not. The worst case was confirmed with and without mechanical key, as a result, the test without mechanical key was the worst case. Therefore the test without mechanical key was performed only.

*The result is rounded off to the second decimal place, so some differences might be observed.

Measurement range : 9 kHz - 3.2 GHz

Test data : APPENDIX

Test result : Pass

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SECTION 6: Automatically deactivate

Test Procedure

The measurement was performed with Electric field strength using a spectrum analyzer.

Test data : APPENDIX

Test result : Pass

SECTION 7: -20 dB and 99 % Occupied Bandwidth

Test Procedure

The test was measured with a spectrum analyzer using a test fixture.

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used
20 dB Bandwidth	150 kHz	1.5 kHz	5.1 kHz	Auto	Peak	Max Hold	Spectrum Analyzer
99 % Occupied Bandwidth	Enough width to display emission skirts	1 to 5 % of OBW	Three times of RBW	Auto	Peak *1)	Max Hold *1)	Spectrum Analyzer

*1) The measurement was performed with Peak detector, Max Hold since the duty cycle was not 100 %.
Peak hold was applied as Worst-case measurement.

Test data : APPENDIX

Test result : Pass

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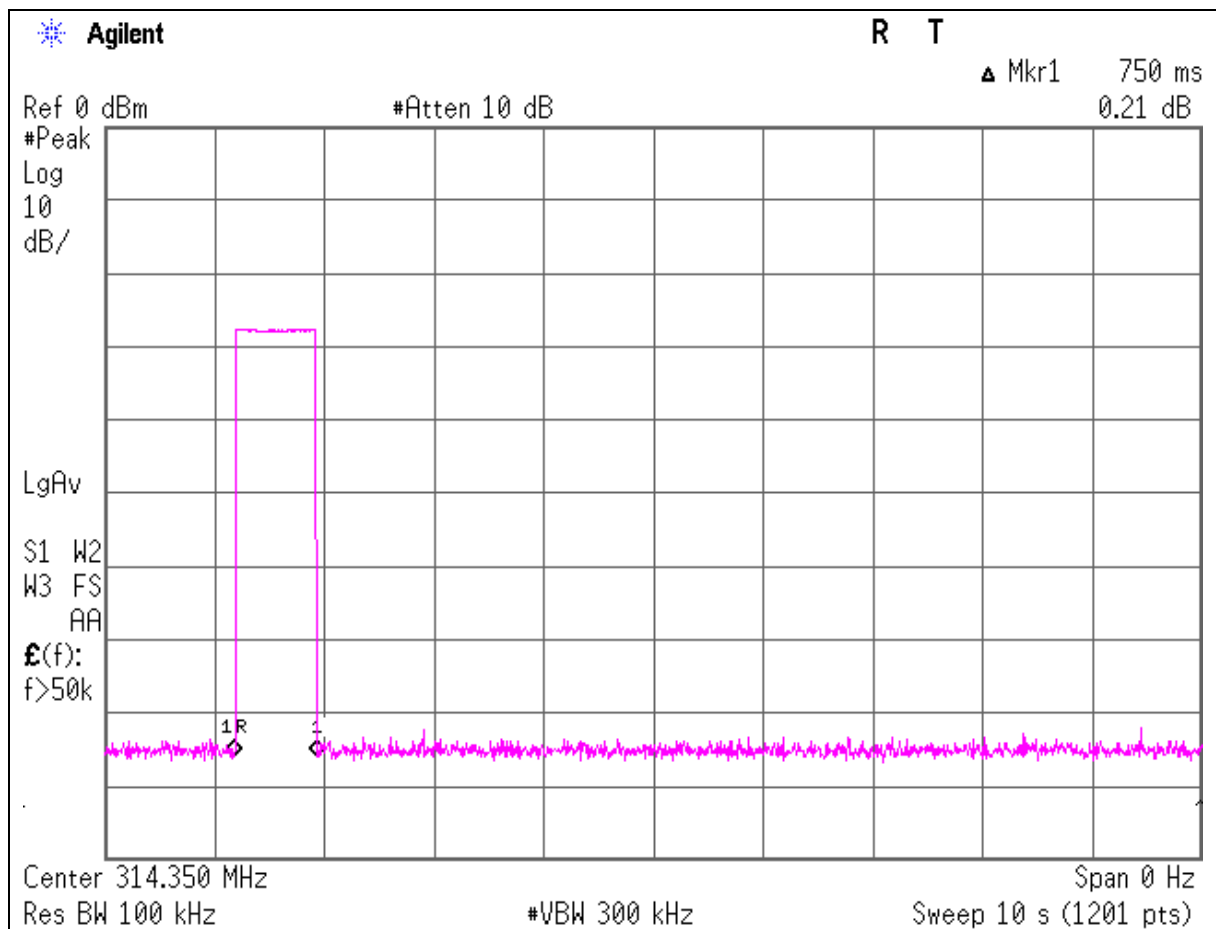
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APPENDIX 1: Test data

Automatically deactivate 314.35 MHz (CH1)

Test place	Ise EMC Lab. No.2 Semi Anechoic Chamber
Report No.	10980809H
Date	10/14/2015
Temperature/ Humidity	24 deg. C / 53 % RH
Engineer	Ken Fujita
Mode	Normal use mode 314.35 MHz (CH1)

Time of Transmitting [sec]	Limit [sec]	Result
0.75	5.00	Pass



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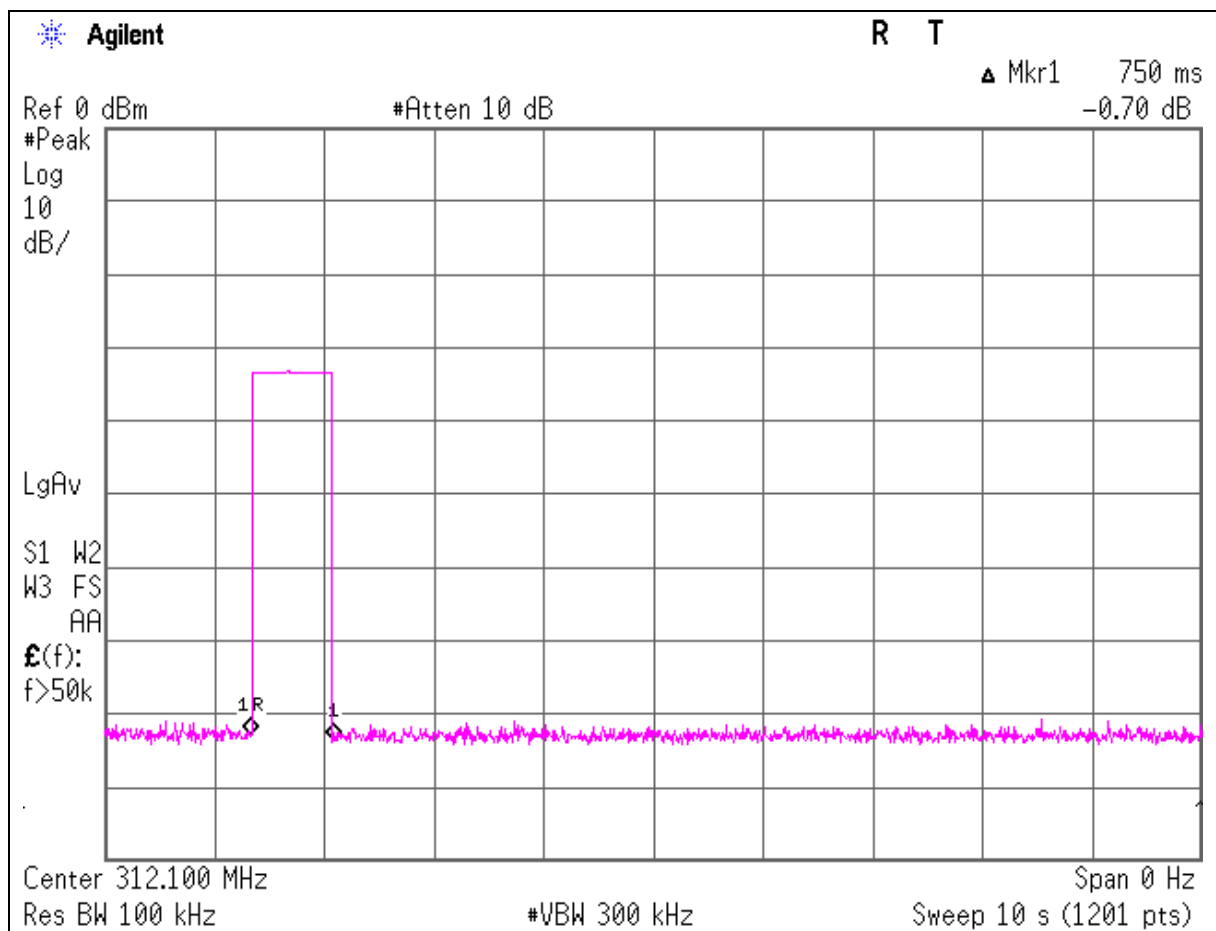
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Automatically deactivate
312.10 MHz (CH2)

Test place	Ise EMC Lab. No.2 Semi Anechoic Chamber
Report No.	10980809H
Date	10/14/2015
Temperature/ Humidity	24 deg. C / 53 % RH
Engineer	Ken Fujita
Mode	Normal use mode 312.10 MHz (CH2)

Time of Transmitting [sec]	Limit [sec]	Result
0.75	5.00	Pass



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Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission) 314.35 MHz (CH1)

Test place : Ise EMC Lab. No.2 Semi Anechoic Chamber
Report No. : 10980809H
Date : 10/14/2015
Temperature/ Humidity : 24 deg. C / 53 % RH
Engineer : Ken Fujita
Mode : Transmitting mode 314.35 MHz (CH1)

PK

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit [dBuV/m]	Margin [dB]		Remark Inside or Outside of Restricted Bands
		Hor	Ver					Hor	Ver		Hor	Ver	
314.350	PK	77.1	74.6	15.0	8.9	27.5	-	73.5	71.0	95.5	22.0	24.5	Carrier
628.700	PK	44.3	44.4	20.0	10.4	28.3	-	46.4	46.5	75.5	29.1	29.0	Outside
943.050	PK	32.4	32.7	23.0	11.5	27.2	-	39.7	40.0	75.5	35.8	35.5	Outside
1257.400	PK	48.9	50.0	25.8	1.9	35.8	-	40.8	41.9	75.5	34.7	33.6	Outside
1571.750	PK	48.8	47.4	26.9	2.1	35.4	-	42.4	41.0	73.9	31.5	32.9	Inside
1886.100	PK	47.7	46.8	28.7	2.3	35.2	-	43.5	42.6	75.5	32.0	32.9	Outside
2200.450	PK	48.3	48.9	29.3	2.4	35.0	-	45.0	45.6	73.9	28.9	28.3	Inside
2514.800	PK	47.9	47.8	29.3	2.6	34.9	-	44.9	44.8	75.5	30.6	30.7	Outside
2829.150	PK	49.9	49.2	29.6	2.7	34.8	-	47.4	46.7	73.9	26.5	27.2	Inside
3143.500	PK	48.1	48.1	29.8	2.9	34.6	-	46.2	46.2	75.5	29.3	29.3	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier)

PK with Duty factor

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit [dBuV/m]	Margin [dB]		Remark
		Hor	Ver					Hor	Ver		Hor	Ver	
314.350	PK	77.1	74.6	15.0	8.9	27.5	0.0	73.5	71.0	75.5	2.0	4.5	Carrier
628.700	PK	44.3	44.4	20.0	10.4	28.3	0.0	46.4	46.5	55.5	9.1	9.0	Outside
943.050	PK	32.4	32.7	23.0	11.5	27.2	0.0	39.7	40.0	55.5	15.8	15.5	Outside
1257.400	PK	48.9	50.0	25.8	1.9	35.8	0.0	40.8	41.9	55.5	14.7	13.6	Outside
1571.750	PK	48.8	47.4	26.9	2.1	35.4	0.0	42.4	41.0	53.9	11.5	12.9	Inside
1886.100	PK	47.7	46.8	28.7	2.3	35.2	0.0	43.5	42.6	55.5	12.0	12.9	Outside
2200.450	PK	48.3	48.9	29.3	2.4	35.0	0.0	45.0	45.6	53.9	8.9	8.3	Inside
2514.800	PK	47.9	47.8	29.3	2.6	34.9	0.0	44.9	44.8	55.5	10.6	10.7	Outside
2829.150	PK	49.9	49.2	29.6	2.7	34.8	0.0	47.4	46.7	53.9	6.5	7.2	Inside
3143.500	PK	48.1	48.1	29.8	2.9	34.6	0.0	46.2	46.2	55.5	9.3	9.3	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

Since the peak emission result satisfied the average limit, duty factor was omitted.
Although Duty of this product was 100% or less, the result of AV (PK with Duty factor) was calculated by applying Duty 100% as worst.

Radiated Emission (Electric Field Strength of Fundamental and Spurious Emission) 312.10 MHz (CH2)

Test place : Ise EMC Lab. No.2 Semi Anechoic Chamber
Report No. : 10980809H
Date : 10/14/2015
Temperature/ Humidity : 24 deg. C / 53 % RH
Engineer : Ken Fujita
Mode : Transmitting mode 312.10 MHz (CH2)

PK

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit [dBuV/m]	Margin [dB]		Remark Inside or Outside of Restricted Bands
		Hor	Ver					Hor	Ver		Hor	Ver	
312.100	PK	77.0	74.5	14.9	8.9	27.5	-	73.3	70.8	95.4	22.1	24.6	Carrier
624.200	PK	43.4	44.9	20.0	10.3	28.4	-	45.3	46.8	75.4	30.1	28.6	Outside
936.300	PK	30.1	30.7	22.9	11.5	27.2	-	37.3	37.9	75.4	38.1	37.5	Outside
1248.400	PK	48.4	50.6	25.8	1.9	35.8	-	40.3	42.5	75.4	35.1	32.9	Outside
1560.500	PK	48.9	48.6	26.8	2.1	35.5	-	42.3	42.0	73.9	31.6	31.9	Inside
1872.600	PK	47.1	48.1	28.7	2.3	35.2	-	42.9	43.9	75.4	32.5	31.5	Outside
2184.700	PK	48.2	48.1	29.3	2.4	35.0	-	44.9	44.8	75.4	30.5	30.6	Outside
2496.800	PK	48.9	47.7	29.3	2.6	34.9	-	45.9	44.7	73.9	28.0	29.2	Inside
2808.900	PK	49.6	48.9	29.6	2.7	34.8	-	47.1	46.4	73.9	26.8	27.5	Inside
3121.000	PK	48.1	47.6	29.8	2.9	34.6	-	46.2	45.7	75.4	29.2	29.7	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier)

PK with Duty factor

Frequency [MHz]	Detector	Reading [dBuV]		Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]		Limit [dBuV/m]	Margin [dB]		Remark
		Hor	Ver					Hor	Ver		Hor	Ver	
312.100	PK	77.0	74.5	14.9	8.9	27.5	0.0	73.3	70.8	75.4	2.1	4.6	Carrier
624.200	PK	43.4	44.9	20.0	10.3	28.4	0.0	45.3	46.8	55.4	10.1	8.6	Outside
936.300	PK	30.1	30.7	22.9	11.5	27.2	0.0	37.3	37.9	55.4	18.1	17.5	Outside
1248.400	PK	48.4	50.6	25.8	1.9	35.8	0.0	40.3	42.5	55.4	15.1	12.9	Outside
1560.500	PK	48.9	48.6	26.8	2.1	35.5	0.0	42.3	42.0	53.9	11.6	11.9	Inside
1872.600	PK	47.1	48.1	28.7	2.3	35.2	0.0	42.9	43.9	55.4	12.5	11.5	Outside
2184.700	PK	48.2	48.1	29.3	2.4	35.0	0.0	44.9	44.8	55.4	10.5	10.6	Outside
2496.800	PK	48.9	47.7	29.3	2.6	34.9	0.0	45.9	44.7	53.9	8.0	9.2	Inside
2808.900	PK	49.6	48.9	29.6	2.7	34.8	0.0	47.1	46.4	53.9	6.8	7.5	Inside
3121.000	PK	48.1	47.6	29.8	2.9	34.6	0.0	46.2	45.7	55.4	9.2	9.7	Outside

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier)

*Other frequency noises omitted in this report were not seen or had enough margin (more than 20dB).

Since the peak emission result satisfied the average limit, duty factor was omitted.
Although Duty of this product was 100% or less, the result of AV (PK with Duty factor) was calculated by applying Duty 100% as worst.

-20dB and 99% Occupied Bandwidth
314.35 MHz (CH1) / 312.10 MHz (CH2)

Test place : Ise EMC Lab. No.2 Semi Anechoic Chamber
Report No. : 10980809H
Date : 10/14/2015
Temperature/ Humidity : 24 deg. C / 53 % RH
Engineer : Ken Fujita
Mode : Transmitting mode 314.35 MHz (CH1) / 312.10 MHz (CH2)

Bandwidth Limit : Fundamental Frequency **312.10** MHz x 0.25% = 780.25 kHz

* The above limit was calculated from more stringent nominal frequency.

* Method of KDB 926416 for systems employing non sweeping frequencies was referred.

314.35MHz

-20dB Bandwidth [kHz]
39.65

312.10MHz

-20dB Bandwidth [kHz]
39.70

-20dB Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
39.65+39.70=79.35	780.25	Pass

Bandwidth Limit : Fundamental Frequency **314.35** MHz x 0.25% = 785.88 kHz

99% Occupied Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
43.68	785.88	Pass

Bandwidth Limit : Fundamental Frequency **312.10** MHz x 0.25% = 780.25 kHz

99% Occupied Bandwidth [kHz]	Bandwidth Limit [kHz]	Result
44.52	780.25	Pass

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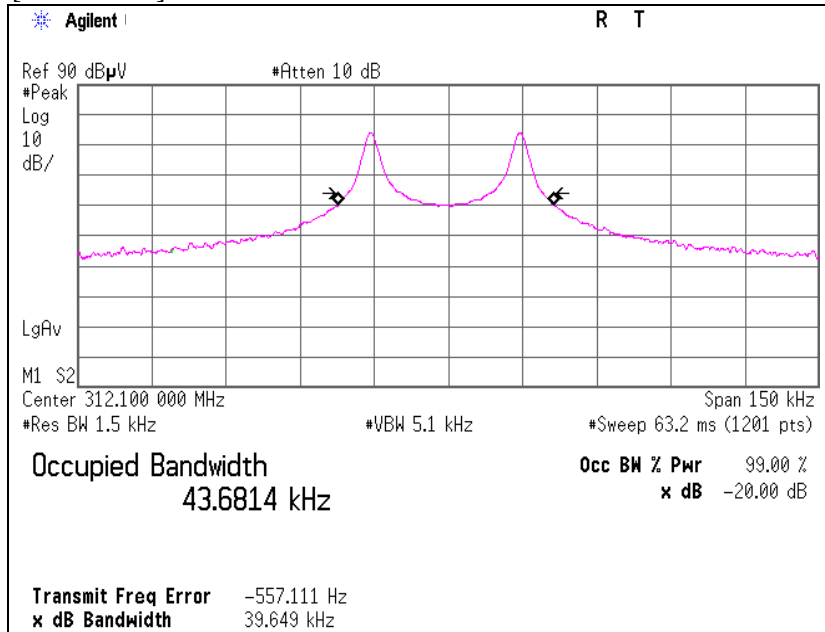
Telephone : +81 596 24 8999

Facsimile : +81 596 24 8124

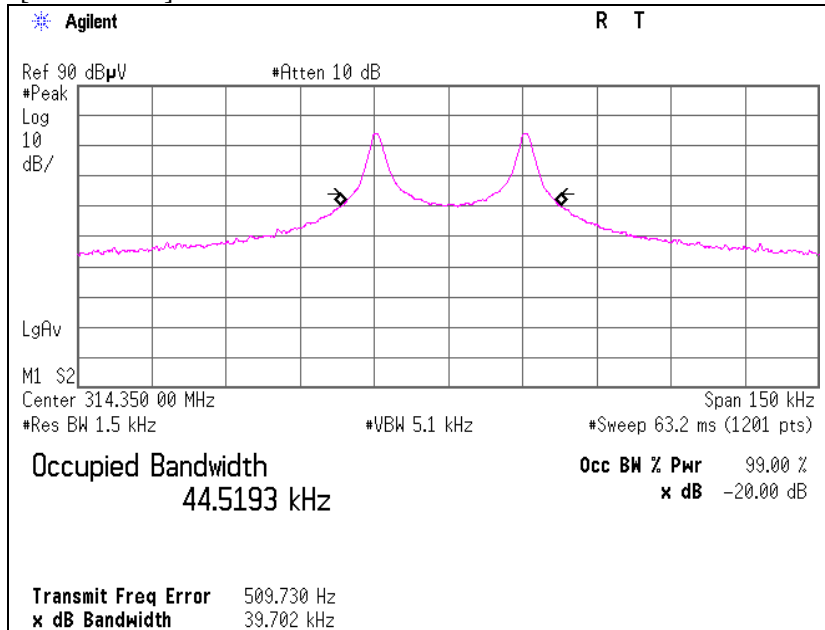
-20dB and 99% Occupied Bandwidth
314.35 MHz (CH1) / 312.10 MHz (CH2)

Test place Ise EMC Lab. No.2 Semi Anechoic Chamber
Report No. 10980809H
Date 10/14/2015
Temperature/ Humidity 24 deg. C / 53 % RH
Engineer Ken Fujita
Mode Transmitting mode 314.35 MHz (CH1) / 312.10 MHz (CH2)

[314.35MHz]



[312.10MHz]



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APPENDIX 2: Test Instruments

EMI test equipment

Control No.	Instrument	Manufacturer	Model No	Serial No	Test Item	Calibration Date * Interval(month)
MAEC-02	Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-06902	RE	2015/07/01 * 12
MOS-22	Thermo-Hygrometer	Custom	CTH-201	0003	RE	2015/01/13 * 12
MJM-14	Measure	KOMELON	KMC-36	-	RE	-
COTS-MEMI	EMI measurement program	TSJ	TEPTO-DV	-	RE	-
MSA-04	Spectrum Analyzer	Agilent	E4448A	US44300523	RE	2014/11/12 * 12
MTR-03	Test Receiver	Rohde & Schwarz	ESCI	100300	RE	2015/06/08 * 12
MBA-02	Biconical Antenna	Schwarzbeck	BBA9106	VHA91032008	RE	2014/10/18 * 12
MLA-02	Logperiodic Antenna	Schwarzbeck	USLP9143	201	RE	2014/10/18 * 12
MCC-12	Coaxial Cable	Fujikura/Agilent	-	-	RE	2015/02/06 * 12
MAT-07	Attenuator(6dB)	Weinschel Corp	2	BK7970	RE	2014/11/11 * 12
MPA-09	Pre Amplifier	Agilent	8447D	2944A10845	RE	2015/09/04 * 12
MHA-06	Horn Antenna 1-18GHz	Schwarzbeck	BBHA9120D	254	RE	2015/02/05 * 12
MCC-168	Microwave Cable	Junkosha	MWX221	1408S016(1m) / 1409S492(5m)	RE	2015/09/24 * 12
MPA-10	Pre Amplifier	Agilent	8449B	3008A02142	RE	2015/01/28 * 12
MLPA-07	Loop Antenna	UL Japan	-	-	RE	Pre Check

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test Item:

RE: Radiated emission, 99 % Occupied Bandwidth, -20 dB bandwidth, Automatically deactivate and Duty cycle tests

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